

Search Notes

Application/Control No.

10/039,852

Examiner

John P. Trimmings

Applicant(s)/Patent under
Reexamination

SHIH ET AL.

Art Unit

2133

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NPL search: test ic pattern input.	9/29/2005	JPT
Dble Patent search: negative. Class search: 714/726, 727, 724. Text strategy attached.	9/29/2005	JPT